





X-FAB 0.35, 0.18, 0.13µm & XMB10 MEMS PROTOTYPING AND VOLUME PRODUCTION

icture Source: X-FAB

EUROPRACTICE offers Multi-Project-Wafer and Volume Production services of X-FAB to academic institutions together with small and medium-sized enterprises.

Why EUROPRACTICE?

- Affordable and easy access to Prototyping and Small Volume Production services for academia and industry.
- MPW (Multi-Project-Wafer) runs for various technologies, including ASICs, Photonics, MEMS and more.
- Advanced packaging, system integration solutions and test services.

Why X-FAB?

- ➤ The world's leading foundry group for analog/mixed-signal semiconductor applications.
- Technologies ranging from 1.0 to 0.13 μm mixed-signal CMOS, special SOI and MEMS long lifetime processes for automotive, industrial, medical and other applications.
- Six manufacturing sites in Germany, France, Malaysia and the USA.

Technology Highlights

XH035: Modular Mixed-Signal Technology with HV Extensions

This technology is based on a single poly triple metal 0.35µm drawn gate length process for digital applications. It features core and process modules such as low Vt, low leakage, embedded non-volatile memory (NVM) and high voltage (HV) options, as well as standard or thick fourth layer of metal, double poly and MIM capacitors and high resistance polysilicon. MOS and bipolar transistors are also available. World class low noise p-mos and n-mos transistors make this technology the first choice for applications requiring very low noise and high signal-to-noise ratios, for instance, for industrial, automotive and telecommunication products. In addition, Noble Metal Au/ Pt finish is available for MLM services.

XH018: Modular Mixed-Signal HV CMOS Technology

Based upon the industrial standard single poly with up to six metal layers 0.18µm drawn gate length Nwell process. It is the industry's first and only 0.18µm technology to integrate high temperature (HT), HV and NVM all in a single platform. It is ideal for SoC applications in the automotive market such as control devices inside combustion engine compartments or electric engine housings with temperature range up to 175°C, as well as emdedded HV applications in the communications, consumer and industrial market.

XT018: Modular HV SOI CMOS Technology

It combines the benefit of SOI wafers with Deep Trench Isolation (DTI) and those of a state-of-the-art six metal layers 0.18-micron process. HV support up to 200V combined with range of NVM options. The XT018 platform is specifically designed for a next generation automotive, industrial and medical applications operating in the temperature range of -40 to 175 °C. Full PDK support for major EDA vendors, extensive device characterization and modeling, comprehensive analog, digital, and memory IPs.

XS018: Specialized Process for Fast Image Sensors

The optional available modules for 4 transistor cells, pinned photo diodes and the stitching capabilities make this technology ideal for large image sensor applications needing high frame rates as used for instance for medical and scientific X-ray cameras. The 3.3V core module allows a low mask count designs. The industrial standard single poly with up to six metal layers 0.18-micron drawn gate length N-well process can also be used for low power SOC application in the automotive, industrial and medical markets. Comprehensive design rules, precise SPICE models, analog and digital libraries, IPs and development kits support the process for major EDA vendors.

XP018: Modular CMOS Power Management

Based upon the industrial standard single poly with up to six metal layers 0.18-micron drawn gate length N-well process, integrated with high voltage and Non-Volatile-Memory modules, the platform is engineered for applications needing an integrated solution and cost efficient process for high performance ICs. Targeted applications are switching applications, lightings, display,etc; operating in temperature range of -40 to 175 °C.

XR013: RF SOI CMOS Technology

The XR013 technology is a RF SOI (CMOS) 0.13 µm generation designed to serve RF applications. It features high-resistive 'trap-rich' SOI substrate (>3 k Ω -cm), low Ron*Coff switch NMOS transistor with minimum L = 0.22 µm, together with vertical parallel plate (VPP) capacitor and Metal-Insulator-Metal (MIM) capacitor.

XMB10 MEMS

Based on Open Platform technology, XMB10 MEMS process supports fabrication of single, double or triple axis inertial sensors (Accelerometers/ Gyroscopes). It is a three wafer process and uses cavity SOI wafer-based technology. Sensor elements are formed by the silicon DRIE process. Optional top and bottom metal layers are possible. Top cap wafer has silicon with etched cavities and bond pad openings. We also offer cost-effective wafer-level packaging by wafer bonding.

Technology Details

XH035 3.3V/5V

3 or 4 Metal layers, optional thick metal 5V or 18V dual gate for HV transistors Isolated MOS module, deep N-well and P-well Operating voltages 45V, 70V, 90V HR polysilicon up to 10 K ohmm/sq MIM capacitor (1.25fF/µm²) Depletion NMOS Module Tiny EEPROM

XH018 1.8V/3.3V

4 or 6 Metal layers, thick metal layer

Triple well isolated CMOS module 10V-45V HV CMOS transistors, 18V gate oxide HV Schottky Diodes Medium R, P-doped polysilicon 960 ohm/sq 1.8V low Vt module additional N-well, P-well MIM (1fF/µm²) or MIMH capacitor (2.3fF/µm²) NVM module for NVRAM and FLASH Support of photodiodes and SPAD

XT018 1.8V/5V

4 or 6 Metal layers, thick metal layer
Deep trench isolation
10-200V HV transistors
Subblock module 1.8V for 1.8V/5.0V PNP
bipolar transistors
7.0V N-type protection diode (DPC)
N-buried high voltage handle wafer diodes
Top side handle wafer contact
HR N-doped polysilicon resistor 6.3 ohm/sq
MIM (1fF/µm²) or MIMH capacitor (2.3fF/µm²)

XS018 1.8V/ 3.3V

4 or 6 Metal layers, thin metal layer
4T based CMOS imaging sensors
Selection of pinned photo diodes
3.3V buried channel NMOS in pixel
Selection of 3.3V low Vt NMOS in pixel
MIM (IfF/µm²) or MIMH capacitor (2.3fF/µm²)
Ik ohm/sq polysilicon resistor module
Flat passivation for microlense or colour filtering, post process

XP018 1.8V/5V

4 or 6 Metal layers, thick metal layer
12V - 60V HV transistors
Medium R P-doped polysilicon resistor 960 ohm/sq
HR P-doped polysilicon resistor 6.7k ohm/sq
MIM (1fF/μm²) or MIMH capacitor (2.3fF/μm²)
Ready-to-use EEPROM memory block
(SONOS based)

XR013

4 to 8 Metal Levels Hybrid Cu/Al, thick metal module 2.5V RF Switches 1.2V Low-noise, high gain , high linearity NFET options for LNA

Low and high value diffusion, poly resistors RF capacitor: MIM (2.1 fF/mm2)

HR P-doped polysilicon resistor 6.7k ohm/sq RF varactors

Regular Vt 1.2V digital CMOS

High-density highVt 1.2V digital CMOS

Would you like to discover more?

X-FAB Technologies

via imec: epxfab@imec.be

via Fraunhofer: virtual-asic@iis.fraunhofer.de

